## To : MICROELECTEK CO. LIMITED

## **PRODUCT SPECIFICATION**

P/N: UN	MK105 B7103KVMF
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Type: Multilayer Ceramic Capacitors (High dielectric type)

Soldering: Reflow only

Issue date: April 21, 2022

Applicable products to RoHS restriction

TAIYO YUDEN CO., LTD.

### Specifications Multilayer Ceramic Capacitor [High dielectric type]

Please check and comply with the usage conditions and precautions described in this specification. Before use, please be sure to verify and validate our products under intended operating environmental conditions with the products being installed in actual devices.

#### 1. Scope

This specification shall apply to multilayer chip type ceramic capacitor (for reflow soldering) used for general electronic equipment. For the details of such equipment, please refer the precautions described in this specification.

#### 2. Part Numbering System

Part number is indicated as follows:

(Example) :	U	MK	105		B	7	103	K	V	MF
	$\bigcirc$		2	(3		Ca	apacitance	5	6	$\overline{O}$

Code

U

2 Mechanical Dimensions						
Code	L×W [mm]					
105	1.0×0.5					

③Dimensional Tolerance

See Table 1.

#### **④Temperature Characteristics**

Rated voltage

[VDC]

50

Characteristic	Capacitance	Temperature	Reference	
	change rate [%]	range [°C]	temperature [°C]	
B7 (X7R)	±15 (EIA)	-55 to +125	25	

5 Capacitance Tolerance

Code	Capacitance tolerance			
K	±10%			
М	±20%			

#### **6**Product Thickness

Code	Thickness [mm]
V	0.5

#### ⑦Packaging

Code	Packaging type
MF	Taping

## 3. Shape, Structure, and Dimension

## Figure 1: Shape and structure



No.	Name	Material
1	Terminal Electrodes (Surface)	Sn Plating
2	Terminal Floatrades	Ni Plating
	reminal Electrodes	Cu Plating
3	External Electrodes	Ni
4	Internal Electrodes	Ni
5	Dielectric	Barium titanate

#### Table 1: Dimensions

Sizo	D. T. 💥		Dimension [Unit: mm]					
SIZE	code	L	W	Т	е			
105	Space	1.0±0.05	0.5±0.05	See Table 2.	0.25±0.10			

**※**D.T. stands for dimensional tolerance.

## 4. Rated Value/Part Number List

## Table 2: Part Number List

Operating temperature range: -55 to +125°C

Part number	Rated voltage (VDC)	Temp. char.	Cap. (µF)	IR (MΩ·µF min.) ※1	DF (% max.)	Measuring conditions Upper : Cap. DF Lower : T/C	Thickness (mm)
UMK105 B7103KVMF	50	X7R	0.01		3.5	1kHz-1.0Vrms 1kHz-1.0Vrms	0.5±0.05

[Notes] %1: Blank indicates 10,000M $\Omega$  min.

#### 5. Functions and Test Methods

#### Test Conditions:

Standard test conditions shall be temperature of 5 to  $35^{\circ}$ C, relative humidity of 45 to 85%, and air pressure of 86 to 106 kPa. Tests shall be conducted at temperature of  $25 \pm 3^{\circ}$ C, relative humidity of 60 to 70% and air pressure of 86 to 106 kPa if test results are suspicious. Unless otherwise specified, all tests shall be conducted under the standard test conditions.

No.	Item	Specified Value	Remarks
1	Operating Temperature Range	Capable of ontinuous operation within the range.	-55 to +125°C
2	Shape and Dimensions	See Fig 1 and Table 1.	
3	Heat Treatment		Initial value shall be measured after test sample is heat-treated at $150 + 0/-10$ °C for an hour and kept at room temperature for 24 ± 2 hours.
4	Voltage Treatment		Initial value shall be measured after test sample is voltage-treated for an hour at temperature and voltage which are specified as test conditions, and kept at room temperature for $24 \pm 2$ hours.
5	Dielectric Withstanding Voltage (between terminals)	No dielectric breakdown or damage	Conforming to EIA RS-198 (1991). 250% of DC rated voltage shall be applied for 1 to 5 seconds. Charging and discharging current shall be 50mA or less.
6	Insulation Resistance (IR)	See Table 2.	Conforming to EIA RS-198 (1991). Rated voltage shall be applied to test sample for 1 minute ± 5 seconds. Charging and discharging current shall be 50 mA or less.
7	Capacitance (Cap.)	See Table 2.	Conforming to EIA RS-198 (1991).Heat treatment specified in this specification shall be conducted prior to measurement.Measuring frequency and voltage shall conform to the table below.Measuring frequencyMeasuring voltage1 kHz ± 10%1.0 ± 0.2 Vrms
8	Dissipation Factor (DF)	See Table 2.	Conforming to EIA RS-198 (1991).Heat treatment specified in this specification shall be conducted prior to measurement.Measuring frequency and voltage shall conform to the table below.Measuring frequencyMeasuring voltage 1 kHz ± 10%1.0 ± 0.2 Vrms

No.	Item	Specified Value	Remarks
9	Temperature Characteristic (T/C)	See P1 for ④.	Heat treatment specified in this specification shall be conducted prior to measurement.Maximum capacitance deviation in both (+) and (-) sides in the range from lowest temperature to highest temperature for capacitor shall be indicated in ratio of variation in reference to capacitance value at reference temperature.Measuring frequency and voltage shall conform to the table below.Measuring FrequencyMeasuring Voltage 
10	Adhesive Force of Terminal Electrodes	Terminal electrodes shall be no exfoliation or a sign of exfoliation.	Test sample shall be soldered to test board shown in Fig. 2, and a force of 5N (0.51 kgf) shall be applied for $30 \pm 5$ seconds.
11	Vibration	Initial performance shall be satisfied.	Conforming to EIA RS-198 (1991). Test sample shall be soldered to board shown in Fig. 2. Heat treatment specified in this specification shall be conducted prior to test. Test conditions: Frequency range: 10-55 Hz Overall amplitude: 1.5 mm Sweeping method: 10-55-10 Hz for 1 minute Two hours each in X, Y, Z directions: 6 hours in total

No.		Item	Specified Value	Remarks					
12	Solderability	,	More than 95% of terminal electrodes shall be covered with fresh solder.	[Eutectic] Solder used shall be [JIS Z 3282 H60A or H63A]. Test sample shall be completely submerged in molten solder at 230 $\pm$ 5°C for 4 $\pm$ 1 seconds.					
				【Pb free】 Solder used shall be [Sn/3.0Ag/0.5Cu]. Test sample shall be completely submerged in molten solder at 245 ± 3°C for 4 ± 1 seconds.					
13	Resistance	Resistance Appearance No abnormality		Conforming to EIA RS-198 (1991).					
	Soldering Heat	Soldering Cap. Change See Table 3. Heat		conducted prior to test. Test sample shall be completely submerged in					
		DF	See Table 3.	molten solder of 270 $\pm$ 5°C for 3 $\pm$ 0.5 seconds. Preheating as shown in the table below shall be					
		IR	Initial value shall be satisfied.	continuously conducted before submersion, and test sample shall be kept at room temperature after test.					
		Dielectric Withstanding Voltage (between terminals)	No dielectric breakdown or damage	No dielectric g breakdown or damage	Voltage damage (between terminals)	Sequence         Temperature (°C)         Time (min.)           1         80 to 100         2 to 5           2         150 to 200         2 to 5			
				Measurement shall be conducted after test sample kept at room temperature for $24 \pm 2$ hours.					
14	Thermal Shock	Appearance	No abnormality	Conforming to EIA RS-198 (1991). Test sample shall be soldered to board shown in					
		Cap. Change	See Table 3.	Fig. 2. Heat treatment specified in this specification shall be					
		DF	See Table 3.	conducted prior to test.					
		IR	Initial value shall be satisfied.	conditions in the following steps 1 to 4 in sequence for the specified time.					
		Dielectric Withstanding	No dielectric	Step Temperature (°C) Time (min.)					
		Voltage (between	damage	1Lowest operating temperature30 ± 3					
		terminals)		2 Ambient temperature 2 to 3					
				3 Highest operating temperature 30 ± 3					
				4   Ambient temperature   2 to 3					
				Temperature cycle shall be repeated five (5) times by this method, and measurement shall be conducted after test sample is kept at room temperature for $24 \pm 2$ hours.					

No.	lte	em	Specified Value	Remarks
15	Humidity (Steady	Appearance	No abnormality	Conforming to EIA RS-198 (1991). Heat treatment specified in this specification shall
	State)	Cap. Change	See Table 3.	be conducted prior to test. Test sample shall be put into constant
		DF	See Table 3.	temperature/humidity bath at 40 $\pm$ 2°C and 90 to 95%RH for 500 +24/-0 hours.
		IR	See Table 3.	Measurement shall be conducted after test sample is kept at room temperature for 24 ± 2 hours.
16	High Temperature	Appearance	No abnormality	Conforming to EIA RS-198 (1991). Voltage treatment specified in this specification
	Loading	Cap. Change	See Table 3.	shall be conducted prior to test. Test sample shall be put in thermostatic oven at
		DF	See Table 3.	maximum operating temperature, and specified DC voltage shall be continuously applied for 1000
		IR	See Table 3.	<ul> <li>+48/-0 hours.</li> <li>(Applied DC voltage is described in Table 3.)</li> <li>Charging and discharging current shall be 50mA or less.</li> <li>Measurement shall be conducted after test sample is kept at room temperature for 24 ± 2 hours.</li> </ul>
17	Humidity Loading	Appearance	No abnormality	Conforming to EIA RS-198 (1991). Voltage treatment specified in this specification
		Cap. Change	See Table 3.	shall be conducted prior to test. Test sample shall be put into constant
		DF	See Table 3.	temperature/humidity bath at 40±2°C and 90 to 95%RH, and DC rated voltage shall be
		IR	See Table 3.	continuously applied for 500 +24/-0 hours. Charging and discharging current shall be 50mA or less. Measurement shall be conducted after test sample
				is kept at room temperature for 24±2 hours.
18	Bending Strength	Appearance	No abnormality	Test sample shall be soldered to test board as shown in Fig. 3.
		Cap. Change	±12.5%	Sample shall be carefully soldered to avoid abnormality such as heat shock. The board is bent 1.0 mm for 10 seconds as shown in Fig. 4. Measurement shall be conducted as the board is bent 1.0 mm.

Table 3: Ca	ip., DF, a	and IR Ch	anges afte	r Test
	• • •		5	

	Resistance to Soldering Heat/ Thermal Shock		Humidity teady state)		High Temperature Loading				Humidity Loading			
Part Number	Cap. chg. rate (%)	DF (% max.)	Cap. chg. rate (%)	DF (% max.)	<b>※</b> 1	Cap. chg. rate (%)	DF (% max.)	<b>※</b> 3	<b>※</b> 1	Cap. chg. rate (%)	DF (% max.)	<b>※</b> 2
UMK105 B7103KVMF	±7.5	3.5	±12.5	5.0		±12.5	5.0	150		±12.5	5.0	

[Notes] ※1: IR after test (MΩ·μF min.): Blank indicates 1000MΩmin.
 ※2: IR after test (MΩ·μF min.): Blank indicates 500MΩmin.

3: Applied voltage (%)

Fig. 2: Board of Adhesive Force of Terminal Electrodes, Vibration, and Thermal Shock Tests



Material: Glass epoxy board [JIS C 6484]

Copper foil (Thickness: 0.035mm)

Solder resist

Remarks: Uniform soldering shall be conducted by using soldering iron or soldering oven. Soldering shall be conducted with care to avoid abnormality such as heat shock.

Fig. 3: Board for Bending Strength Test



Material: Glass epoxy board [JIS C 6484]

Copper foil (Thickness: 0.035 mm)Solder resist

Size (L x W)	а	b	С
1.0×0.5	0.4	1.5	0.5
		[ו	Jnit: mm]

Fig. 4: Bending Strength Test Method



Apply pressure at the rate of 0.5 mm/sec. until amount of deflection reaches 1.0 mm.

#### 6. Basic Information and Others

#### 6-1-1. Equipment Intended for Use

The products listed in this specification are intended for general purpose and standard use in general electronic equipment (e.g., AV equipment, OA equipment, home electric appliances, office equipment, information and communication equipment including, without limitation, mobile phone, and PC) and other equipment specified in catalog or the individual product specification sheets.

TAIYO YUDEN has the line-up of the products intended for use in automotive electronic equipment, telecommunications infrastructure and industrial equipment, or medical devices classified as GHTF Classes A to C (Japan Classes I to III). Therefore, when using our products for these equipment, please check available applications specified in catalog or the individual product specification sheets and use the corresponding products.

#### 6-1-2. Equipment Requiring Inquiry

Please be sure to contact TAIYO YUDEN for further information before using the products listed in this speciation for the following equipment (excluding intended equipment as specified in catalog or the individual product specification sheets) which may cause loss of human life, bodily injury, serious property damage and/or serious public impact due to a failure or defect of the products and/or malfunction attributed thereto.

- (1) Transportation equipment (automotive powertrain control system, train control system, and ship control system, etc.)
- (2) Traffic signal equipment
- (3) Disaster prevention equipment, crime prevention equipment
- (4) Medical devices classified as GHTF Class C (Japan Class III)
- (5) Highly public information network equipment, data processing equipment (telephone exchange, and base station, etc.)
- (6) Any other equipment requiring high levels of quality and/or reliability equal to the equipment listed above

#### 6-1-3. Equipment Prohibited for Use

Please do not incorporate our products into the following equipment requiring extremely high levels of safety and/or reliability.

- (1) Aerospace equipment (artificial satellite, rocket, etc.)
- (2) Aviation equipment \*1
- (3) Medical devices classified as GHTF Class D (Japan Class IV), implantable medical devices \*2
- (4) Power generation control equipment (nuclear power, hydroelectric power, thermal power plant control system, etc.)
- (5) Undersea equipment (submarine repeating equipment, underwater work equipment, etc.)
- (6) Military equipment
- (7) Any other equipment requiring extremely high levels of safety and/or reliability equal to the equipment listed above

\*Notes:

- 1. There is a possibility that our products can be used only for aviation equipment that does not directly affect the safe operation of aircraft (e.g., in-flight entertainment, cabinlight, electric seat, cooking equipment) if such use meets requirements specified separately by TAIYO YUDEN. Please be sure to contact TAIYO YUDEN for further information before using our products for such aviation equipment.
- 2. Implantable medical devices contain not only internal unit which is implanted in a body, but also external unit which is connected to the internal unit.

#### 6-1-4. Limitation of Liability

Please note that unless you obtain prior written consent of TAIYO YUDEN, TAIYO YUDEN shall not be in any way responsible for any damages incurred by you or third parties arising from use of the products listed in this specification for any equipment that is not intended for use by TAIYO YUDEN, or any equipment requiring inquiry to TAIYO YUDEN or prohibited for use by TAIYO YUDEN as described above.

#### Safety Design

When using our products for high safety and/or reliability-required equipment or circuits, please fully perform safety and/or reliability evaluation. In addition, please install (i) systems equipped with a protection circuit and a protection device and/or (ii) systems equipped with a redundant circuit or other system to prevent an unsafe status in the event of a single fault for a failsafe design to ensure safety.

#### 6-2. Manufacturing site

TAIYO YUDEN CO., LTD. (JAPAN) TAIYO YUDEN (GUANG DONG) CO., LTD. (CHINA) TAIYO YUDEN (SARAWAK) SDN. BHD (MALAYSIA)

#### 6-3. Precautions in Usage

•This specification does not cover the products when Sn-Zn lead free solder is used.

•When the products are used in places where dew condensation develops and/or where corrosive gas such as hydrogen sulfide, sulfurous acid, or chlorine exists in the air, insulation (dielectric) deterioration may occur. Please do not use capacitors under such environmental conditions.

#### 6-4. Storage Conditions

- •Temperature and humidity in storage area shall be controlled carefully to maintain the solderability of terminal electrodes and to keep the packaging material in good condition. Humidity should especially be kept as low as possible.
- •Recommended conditions

Ambient temperature: 30°C or below

Humidity: 20 to 70% RH

The ambient temperature must be kept from 5 to 40°C. Even under ideal storage conditions, capacitor electrode solderability decreases with time. Therefore, ceramic chip capacitors should be used within six (6) months from the time of delivery. If the period is exceeded, please check solderability before using the capacitors.

•The packaging material should be kept where no chlorine or sulfur exists in the air.

#### 6-5. RoHS Compliance

- •The products conform to RoHS.
- "RoHS compliance" means that the products do not contain lead, cadmium, mercury, hexavalent chromium, PBB, PBDE, DBP, DEHP, BBP, or DIBP referring to Directive (EU)2015/863 except other non-restricted substances or impurities which cannot be technically removed at refining process.
- •The products are halogen-free products.

#### 6-6. Resin Coating:

- ·Coating/molding capacitors with resin may have negative effects on the functions of the products.
- •When the products are coated/molded with resin, please check effects on the products by analyzing them in actual applications/devices before use.

### 7. Packaging

[Tape Packaging: 105 Type (thickness code : V)]

◎Tape packaging type (products with thickness code V): Paper tape

Dimensions [Unit: mm] ※1

Туре	А	В
	0.65 ± 0.1	1.15 ± 0.1
	0.7 ± 0.1 ※2	1.2 ± 0.1 ※2
105	0.74 ± 0.08 💥 3	1.34 ± 0.08 💥 3
	0.8 ± 0.1 💥 4	1.4 ± 0.1 💥 4
	0.88 ± 0.08 🔆5	1.5 ± 0.08 🔆5

#### Dimensions [Unit: mm]

Туре	С	D	E	F	G	Н	J	t ※1
105	8.0 ± 0.3	3.5 ± 0.05	1.75 ± 0.1	2.0 ± 0.05	2.0 ± 0.05	4.0 ± 0.1	φ1.5	0.8 max. 0.85 max. <b>※</b> 4
							+0.1/-0	0.95 max. ※5

 $\,\, \ensuremath{\overset{\scriptstyle\triangleleft}{\times}}\,$  1. A, B, t: Sufficient clearances are secured.

- ※ 2. \*MK105A\*\*\*\*\*V\*\*
- ※ 3. \*MK105B\*\*\*\*\*V\*\*
- ₩ 4. \*MK105C\*\*\*\*\*V\*\*
- ※ 5. \*MK105E\*\*\*\*\*V\*\*



## [Tape Packaging: 105 Type]

Dimensions of Reel [Unit: mm]

Туре	A	В	С	D	E	W	t	R
105	φ 178 ± 2.0	φ 50 min.	φ 13.0 ± 0.2	$\phi$ 21.0 ± 0.8	2.0 ± 0.5	10.0 ± 1.5	2.5 max.	1.0



[Tape Packaging: 105 Type (thickness code : V)]

- 1) Taping shall be right-sided wound. Sprocket hole shall be on the right side against the pull-out direction.
- 2) Either the width side (W) or the thickness side (T) of the products below faces up at random when the products are inserted in the chip cavities. (thickness code V)
- 3)There shall be blank spaces in each reel tape as shown in the following figure.
  - Leader part 400mm min.
  - Leader part (Blank part) 100mm min.
  - Trailer (Blank part) 160mm min.



- 4) Top tape and bottom tape (only thickness rank V) of paper taping shall not be crossed over sprocket holes.
- 5) Paper tape shall not be seamed.
- 6) Tensile strength of the tape is 5N (0.51kgf) or over.
- 7) The number of the chip missing from tape reel shall be one (1) piece at a maximum per reel.
- 8) The number of packaged chips per reel is shown in the table below.
- 9) Label indicating part No., quantity and control No. shall be attached to the outside of reel.
- 10) Peeling strength of top tape shall be 0.1 to 0.7N (10.2 to 71.4gf) when top tape is peeled from carrier tape at an angle of 0 to 20 degrees.



Quantity of taping package

Туре	Thickness [Unit: mm] (Thickness code)	Quantity (pcs/reel)	Carrier tape
105	0.5 (V)	10,000	Paper

#### [Packaging Mode]



[105 size]

Code	А	В	С	No. of reels	
Size	100	105	70	5 reels max.	
SIZE	190	105	140	10 reels max.	
Material: Paper [Unit: mm]					

[Unit: mm]

(The size is only for reference.)

Note:

Labels are attached on reels/boxes only after components passed all inspections. Labeled products: Acceptance components

## [Composition of shipping lot number]



- ① Year of production (The last numeral of the Christian era. Year  $2020 \rightarrow 0$ )
- ② Month of production (See the table below.)
- ③ Sequence number is alphanumeric including space.

Month	1	2	3	4	5	6	7	8	9	10	11	12
Code	А	В	С	D	Е	F	G	Н	J	К	L	М

## **Recommended Soldering Profiles for Lead-free Solder Paste**



\*Allowable number of reflow soldering: 2 times max.



should be conducted with soldering iron as boards and components are maintained at sufficient temperatures. \*The soldering iron should not directly touch the components. \*Allowable number of hand soldering: **1 time max.** \*Recommendation: Use 20W-soldering iron with the 1φ-tip or less.

Temperature in usage of Pb-free solder (Sn-3Ag-0.5Cu)

Case size	Soldering iron tip temp	Preheating temp.
3216-type max.	≦350°C	≧150°C
3225-type min.	≦280°C	≧150°C

\*\*Note: The above profiles are the maximum allowable soldering condition; therefore, these profiles are not always recommended.

Operating conditions for guarantee of the products are as described in the specification.

Please note that TAIYO YUDEN CO., LTD. shall not be responsible for any failure and/or abnormality which are caused by use under the conditions other than aforesaid operating conditions.

- Before use, please be sure to verify and validate our products under intended operating environmental conditions with the products being installed in actual devices.
- Information contained in this specification is intended to convey examples of typical performances and/or applications of our products and is not intended to make any warranty with respect to the intellectual property rights or any other related rights of TAIYO YUDEN or any third parties nor grant any license under such rights.
- Please note that the scope of warranty for our products is limited to the delivered our products themselves and TAIYO YUDEN shall not be in any way responsible for any damages resulting from a failure or defect in our products. Notwithstanding the foregoing, if there is a written agreement (e.g., supply and purchase agreement, quality assurance agreement) signed by TAIYO YUDEN and your company, TAIYO YUDEN will warrant our products in accordance with such agreement.
- The contents of this specification are applicable to our products which are purchased from our sales offices or authorized distributors (hereinafter "TAIYO YUDEN's official sales channel"). Please note that the contents of this specification are not applicable to our products purchased from any seller other than TAIYO YUDEN's official sales channel.
- Caution for Export

Some of our products listed in this specification may require specific procedures for export according to "U.S. Export Administration Regulations", "Foreign Exchange and Foreign Trade Control Law" of Japan, and other applicable regulations. Should you have any questions on this matter, please contact our sales staff.

## PRECAUTIONS

1. Circuit Design	
	◆Verification of operating environment, electrical rating and performance
	1. A malfunction of equipment in fields such as medical, aerospace, nuclear control, etc. may cause serious harm to human life or have severe social ramifications.
	Therefore, any capacitors to be used in such equipment may require higher safety and reliability, and shall be clearly differentiated from them used in general purpose applications.
Precautions	◆Operating Voltage (Verification of Rated voltage)
	1. The operating voltage for capacitors must always be their rated voltage or less.
	If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages shall be the rated voltage or less.
	For a circuit where an AC or a pulse voltage may be used, the sum of their peak voltages shall also be the rated voltage or less.
	2. Even if an applied voltage is the rated voltage or less reliability of capacitors may be deteriorated in case that either a high frequency AC
	voltage or a pulse voltage having rapid rise time is used in a circuit.

2. PCB Design	◆Pattern of 1 When	confie									
	Pattern of 1 When	onfie									
Precautions	There (1) E (2) W ♦ Pattern of After cal cutting, b pattern of	capa efore, xcess appr /hen r solde config pacito pacito pacito	urations (Des citors are mou- the following i ivive solder app opriate land-pa- nore than one er-resist. ;urations (Cap ors are mounte inspection, mo- urations and p-	ign of Land-p inted on PCE tems must be blied can cau atterns for pro- component a acitor layout ed on boards, unting of addi ositions of ca	atterns) as, the amour carefully con se mechanica oper amount c re jointly sold on PCBs) they can be itional parts, a pacitors shall	It of solder u sidered in the Il stresses wh of solder. ered onto the subjected to n ssembly into t be carefully c	sed (size of design of land ich lead to c same land, ea mechanical st he chassis, w onsidered to r	fillet) can di d patterns: hip breaking ach componer resses in sub ave soldering minimize stres	rectly affect or cracking. nt's soldering sequent manu of the boards ases.	the capacitor Therefore, plo point shall be ufacturing pro , etc.). For thi	performance. ease consider separated by cesses (PCB s reason, land
	◆Pattern of The follo (1) Rec ●Mul (unit: Wav Size ∠ E C	config omme tilaye mm) ve-so pe L W A 3 3	turations (Des diagrams and t ended land dim r Ceramic Cap Idering 1.6 0.8 0.8 to 1.0 0.5 to 0.8 0.6 to 0.8	ign of Land-p ables show so ensions for ty acitors : Reco 212 2.0 1.25 1.0 to 1.4 0.8 to 1.5 0.9 to 1.2	atterns) precal chip cap mmended lan 316 3.2 1.6 1.8 to 2.5 0.8 to 1.7 1.2 to 1.6	of recommen acitors d dimensions 325 3.2 2.5 1.8 to 2.5 0.8 to 1.7 1.8 to 2.5	ded land patte - -	erms to prever	the excessive s Land pattern: Chip capacito	solder amount:	S. Ider-resist
Technical	Refl	ow-s	oldering								
considerations	Тур	be .	021	042	063	105	107	212	316	325	432
	Size	L	0.25	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5
		W	0.125	0.2	0.3	0.5	8.0	1.25	1.6	2.5	3.2
	A		0.095~0.135	0.15~0.25	0.20~0.30	0.45~0.55	0.8~1.0	0.8~1.2	1.8~2.5	1.8~2.5	2.5~3.5
	В		0.085~0.125	0.15~0.20	0.20~0.30	0.40~0.50	0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5	1.5~1.8
	Note:	Recor	nmended land	size might he	different acc	ording to the a	llowance of t	0.9~1.0 he size of the	product	1.0~3.2	2.370 3.5
	LWE (unit: Size A E	C: Romm) pe L W	105 0.52 1.0 0.18~0.22 0.2~0.25 0.9~1.1	107 0.8 1.6 0.25~0.3 0.3~0.4 1.5~1.7	212 1.25 2.0 0.5~0.7 0.4~0.5 1.9~2.1	oldering	nowance of u	ne size or the		w	



#### ◆Pattern configurations (Capacitor layout on PCBs)

1-1. The following is examples of good and bad capacitor layouts ; capacitors shall be located to minimize any possible mechanical stresses from board warp or deflection.



1-2. The amount of mechanical stresses given will vary depending on capacitor layout. Please refer to diagram below.



1–3. When PCB is split, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, please consider the PCB, split methods as well as chip location.

3. Mounting			
Precautions	<ul> <li>Adjustment of mounting machine         <ol> <li>When capacitors are mounted on P</li> <li>Maintenance and inspection of mou</li> </ol> </li> <li>Selection of Adhesives         <ol> <li>When chips are attached on PCBs following factors are appropriatel hardening period. Therefore, pleas</li> </ol> </li> </ul>	CB, excessive impact load shall not be impo nting machines shall be conducted periodica s with adhesives prior to soldering, it may y checked : size of land patterns, type of e contact us for further information.	osed on them. ally. cause capacitor characteristics degradation unless th f adhesive, amount applied, hardening temperature an
	<ul> <li>Adjustment of mounting machine</li> <li>When the bottom dead center of a this, the following points shall be a (1) The bottom dead center of the (2) The pressure of nozzle shall be (3) To reduce the amount of deflect used on the other side of placement:</li> </ul>	pick-up nozzle is too low, excessive force i considerable. e pick-up nozzle shall be adjusted to the su e adjusted between 1 and 3 N static loads. ction of the board caused by impact of the p the PCB. The following diagrams show so	is imposed on capacitors and causes damages. To avoi rface level of PCB without the board deflection. pick-up nozzle, supporting pins or back-up pins shall b pome typical examples of good and bad pick-up nozzl
	Item	Improper method	Proper method
	Single-sided mounting	chipping or cracking	supporting pins -L or back-up pins
	Double-sided mounting	chipping / or cracking	supporting pins or back-up pins
Technical considerations	<ul> <li>2. As the alignment pin is worn out, a impact on the capacitors. To avoid this, the monitoring of th the pin shall be conducted periodid</li> <li>Selection of Adhesives Some adhesives may cause IR deterior stresses on the capacitors and lead components. Therefore, the following (1) Required adhesive characteristic <ul> <li>a. The adhesive shall be strong</li> <li>b. The adhesive shall have good</li> <li>d. The adhesive shall be used di</li> <li>e. The adhesive shall have corrog</li> <li>g. The adhesive shall have exce</li> <li>b. The adhesive shall have exce</li> </ul> </li> </ul>	djustment of the nozzle height can cause cl e width between the alignment pins in the s cally. ration. The different shrinkage percentage of to cracking. Moreover, too little or too mu precautions shall be noted in the application s enough to hold parts on the board during th cient strength at high temperatures. coating and thickness consistency. uring its prescribed shelf life. bidly. sion resistance. llent insulation characteristics. mission of toxic masses and no effect on the	hipping or cracking of capacitors because of mechanic topped position, maintenance, check and replacement of between the adhesive and the capacitors may result ich adhesive applied to the board may adversely affe n of adhesives. he mounting & solder process.
	h. The adhesive shall have no er (2) The recommended amount of adh [Recommended condition] Figure 212/316 cases a 0.3m b 100 to c Adhesives shall	mission of toxic gasses and no effect on the nesives is as follows; Amoun sizes as examples im min to 120 µm not contact land	After capacitor are bonded

	♦ Selection of Flux
	Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use
	(1) Flux used shall be less than or equal to 0.1 wt%( in Cl equivalent) of halogenated content. Flux having a strong acidity content sh not be applied.
	(2) When shall capacitors are soldered on boards, the amount of flux applied shall be controlled at the optimum level.
Precautions	(3)When water-soluble flux is used, special care shall be taken to properly clean the boards.
	◆ Soldering
	Temperature, time, amount of solder, etc. shall be set in accordance with their recommended conditions.
	Sn-Zn solder paste can adversely affect MLCC reliability.
	Please contact us prior to usage of Sn-Zn solder.



2 The soldering iron shall not directly touch capacitors. soldering for 1 times.

5. Cleaning	
Precautions	<ul> <li>Cleaning conditions</li> <li>1. When PCBs are cleaned after capacitors mounting, please select the appropriate cleaning solution in accordance with the intended use of the cleaning. (e.g. to remove soldering flux or other materials from the production process.)</li> <li>2. Cleaning condition shall be determined after it is verified by using actual cleaning machine that the cleaning process does not affect capacitor's characteristics.</li> </ul>
Technical considerations	<ol> <li>The use of inappropriate cleaning solutions can cause foreign substances such as flux residue to adhere to capacitors or deteriorate their outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).</li> <li>Inappropriate cleaning conditions (insufficient or excessive cleaning) may adversely affect the performance of the capacitors. In the case of ultrasonic cleaning, too much power output can cause excessive vibration of PCBs which may lead to the cracking of capacitors or the soldered portion, or decrease the terminal electrodes' strength. Therefore, the following conditions shall be carefully checked;</li> <li>Ultrasonic output : 20 W/2 or les Ultrasonic frequency : 40 kHz or less</li> </ol>

6. Resin coating and mold			
Precautions	<ol> <li>With some type of resins, decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance.</li> <li>When a resin's hardening temperature is higher than capacitor's operating temperature, the stresses generated by the excessive heat may lead to damage or destruction of capacitors. The use of such resins, molding materials etc. is not recommended.</li> </ol>		
7 Handling			

Precautions	<ul> <li>Splitting of PCB         <ol> <li>When PCBs are split after components mounting, care shall be taken so as not to give any stresses of deflection or twisting to the board</li> <li>Board separation shall not be done manually, but by using the appropriate devices.</li> </ol> </li> <li>Mechanical considerations         Be careful not to subject capacitors to excessive mechanical shocks.         <ol> <li>If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used.</li> </ol> </li> </ul>
Frecautions	<ul> <li>We channed considerations</li> <li>Be careful not to subject capacitors to excessive mechanical shocks.</li> <li>(1) If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used.</li> <li>(2) Please be careful that the mounted components do not come in contact with or bump against other boards or components.</li> </ul>

8. Storage condit	ions
Precautions	<ul> <li>Storage</li> <li>1. To maintain the solderability of terminal electrodes and to keep packaging materials in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible.</li> <li>Recommended conditions <ul> <li>Ambient temperature : Below 30°C</li> <li>Humidity : Below 70% RH</li> <li>The ambient temperature must be kept below 40°C. Even under ideal storage conditions, solderability of capacitor is deteriorated as time passes, so capacitors shall be used within 6 months from the time of delivery.</li> <li>Ceramic chip capacitors shall be kept where no chlorine or sulfur exists in the air.</li> </ul> </li> <li>2. The capacitance values of high dielectric constant capacitors will gradually decrease with the passage of time, so care shall be taken to design circuits. Even if capacitance value decreases as time passes, it will get back to the initial value by a heat treatment at 150°C for 1 hour.</li> </ul>
Technical considerations	If capacitors are stored in a high temperature and humidity environment, it might rapidly cause poor solderability due to terminal oxidation and quality loss of taping/packaging materials. For this reason, capacitors shall be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.
*RCR-2335(Sa	fety Application Guide for fixed ceramic capacitors for use in electronic equipment) is published by JEITA.

Please check the guide regarding precautions for deflection test, soldering by spot heat, and so on.

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